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**PXIe-6361**

## DEVICE SPECIFICATIONS

# NI 6361

X Series Data Acquisition: 2 MS/s, 16 AI, 24 DIO, 2 AO

Français	Deutsch	日本語	한국어	简体中文
<a href="http://ni.com/manuals">ni.com/manuals</a>				

The following specifications are typical at 25 °C, unless otherwise noted. For more information about the NI 6361, refer to the *X Series User Manual* available at [ni.com/manuals](http://ni.com/manuals).

## Analog Input

Number of channels	8 differential or 16 single ended
ADC resolution	16 bits
DNL	No missing codes guaranteed
INL	Refer to the <i>AI Absolute Accuracy</i> section.
Sample rate	
Single channel maximum	2.00 MS/s
Multichannel maximum (aggregate)	1.00 MS/s
Minimum	No minimum
Timing resolution	10 ns
Timing accuracy	50 ppm of sample rate
Input coupling	DC
Input range	±0.1 V, ±0.2 V, ±0.5 V, ±1 V, ±2 V, ±5 V, ±10 V
Maximum working voltage for analog inputs (signal + common mode)	±11 V of AI GND
CMRR (DC to 60 Hz)	100 dB
Input impedance	
Device on	
AI+ to AI GND	>10 GΩ in parallel with 100 pF
AI- to AI GND	>10 GΩ in parallel with 100 pF

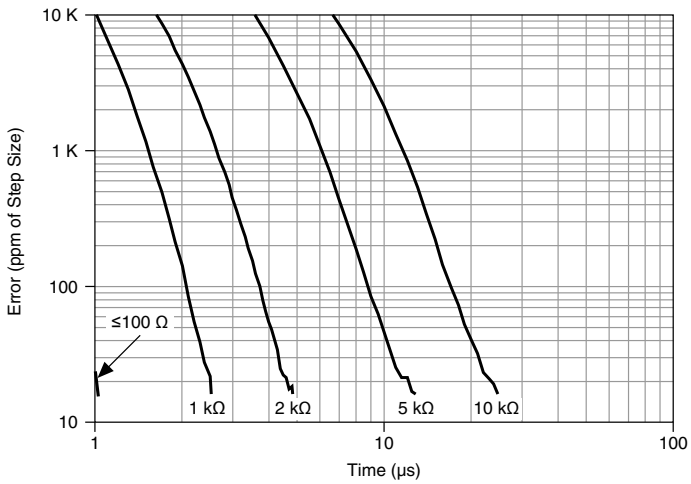
Device off	
AI+ to AI GND	820 $\Omega$
AI- to AI GND	820 $\Omega$
Input bias current	$\pm 100$ pA
Crosstalk (at 100 kHz)	
Adjacent channels	-75 dB
Non-adjacent channels	-95 dB
Small signal bandwidth (-3 dB)	1.7 MHz
Input FIFO size	2,047 samples
Scan list memory	4,095 entries
Data transfers	
PCIe/PXIe	DMA (scatter-gather), programmed I/O
USB	USB Signal Stream, programmed I/O
Overvoltage protection for all analog input and sense channels	
Device on	$\pm 25$ V for up to two AI pins
Device off	$\pm 15$ V for up to two AI pins
Input current during overvoltage condition	$\pm 20$ mA max/AI pin

## Settling Time for Multichannel Measurements

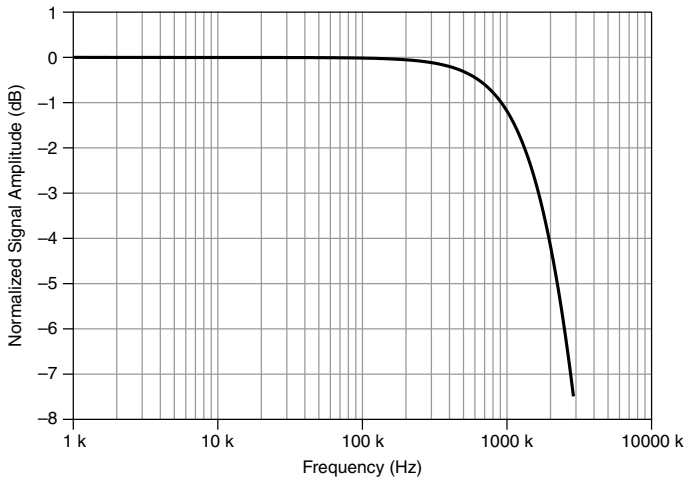
Range	$\pm 60$ ppm of Step ( $\pm 4$ LSB for Full-Scale Step)	$\pm 15$ ppm of Step ( $\pm 1$ LSB for Full-Scale Step)
$\pm 10$ V, $\pm 5$ V, $\pm 2$ V, $\pm 1$ V	1 $\mu$ s	1.5 $\mu$ s
$\pm 0.5$ V	1.5 $\mu$ s	2 $\mu$ s
$\pm 0.2$ V, $\pm 0.1$ V	2 $\mu$ s	8 $\mu$ s

# Typical Performance Graphs

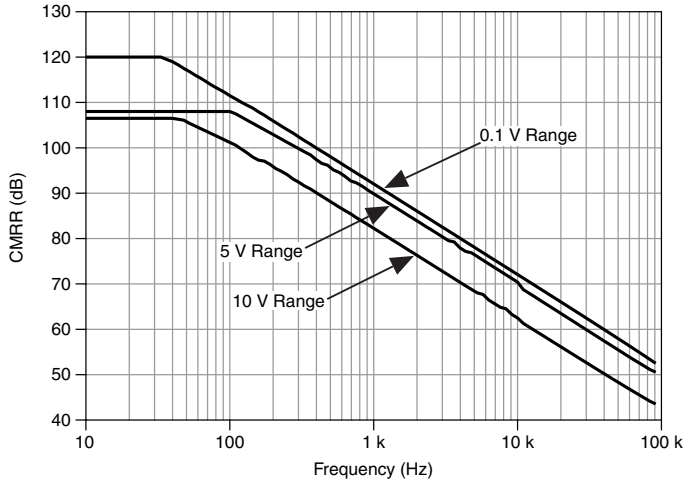
**Figure 1.** Settling Error versus Time for Different Source Impedances



**Figure 2.** AI <0..15> Small Signal Bandwidth



**Figure 3. AI <0..15> CMRR**



## AI Absolute Accuracy

**Table 1. AI Absolute Accuracy**

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, $\sigma$ ( $\mu$ Vrms)	Absolute Accuracy at Full Scale ( $\mu$ V)
10	-10	48	13	21	315	1,660
5	-5	55	13	21	157	870
2	-2	55	13	24	64	350
1	-1	65	17	27	38	190
0.5	-0.5	68	17	34	27	100
0.2	-0.2	95	27	55	21	53
0.1	-0.1	108	45	90	17	33

For more information about absolute accuracy at full scale, refer to the [AI Absolute Accuracy Example](#) section.

Gain tempco	13 ppm/°C
Reference tempco	1 ppm/°C
INL error	60 ppm of range



**Note** Accuracies listed are valid for up to two years from the device external calibration.

## AI Absolute Accuracy Equation

$$\text{AbsoluteAccuracy} = \text{Reading} \cdot (\text{GainError}) + \text{Range} \cdot (\text{OffsetError}) + \text{NoiseUncertainty}$$

$$\text{GainError} = \text{ResidualGainError} + \text{GainTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{ReferenceTempco} \cdot (\text{TempChangeFromLastExternalCal})$$

$$\text{OffsetError} = \text{ResidualOffsetError} + \text{OffsetTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{INLError}$$

$$\text{NoiseUncertainty} = \frac{\text{Random Noise} \cdot 3}{\sqrt{10,000}} \text{ for a coverage factor of } 3 \sigma \text{ and averaging } 10,000 \text{ points.}$$

## AI Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- $\text{TempChangeFromLastExternalCal} = 10 \text{ }^\circ\text{C}$
- $\text{TempChangeFromLastInternalCal} = 1 \text{ }^\circ\text{C}$
- $\text{number\_of\_readings} = 10,000$
- $\text{CoverageFactor} = 3 \sigma$

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

$$\text{GainError} = 48 \text{ ppm} + 13 \text{ ppm} \cdot 1 + 1 \text{ ppm} \cdot 10 = 71 \text{ ppm}$$

$$\text{OffsetError} = 13 \text{ ppm} + 21 \text{ ppm} \cdot 1 + 60 \text{ ppm} = 94 \text{ ppm}$$

$$\text{Noise Uncertainty} = \frac{315 \mu\text{V} \cdot 3}{\sqrt{10,000}} = 9.4 \mu\text{V}$$

$$\text{AbsoluteAccuracy} = 10 \text{ V} \cdot (\text{GainError}) + 10 \text{ V} \cdot (\text{OffsetError}) + \text{NoiseUncertainty} = 1,660 \mu\text{V}$$

## Analog Triggers

Number of triggers	1
Source	AI <0..15>, APFI 0
Functions	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Source level	
AI <0..15>	±Full scale
APFI 0	±10 V
Resolution	16 bits
Modes	Analog edge triggering, analog edge triggering with hysteresis, and analog window triggering
Bandwidth (-3 dB)	
AI <0..15>	3.4 MHz
APFI 0	3.9 MHz
Accuracy	±1% of range
APFI 0 characteristics	
Input impedance	10 kΩ
Coupling	DC
Protection, power on	±30 V
Protection, power off	±15 V

## Analog Output

Number of channels	2
DAC resolution	16 bits
DNL	±1 LSB
Monotonicity	16 bit guaranteed
Maximum update rate (simultaneous)	
1 channel	2.86 MS/s
2 channels	2.00 MS/s
Timing accuracy	50 ppm of sample rate
Timing resolution	10 ns

Output range	$\pm 10\text{ V}$ , $\pm 5\text{ V}$ , $\pm$ external reference on APFI 0
Output coupling	DC
Output impedance	$0.2\ \Omega$
Output current drive	$\pm 5\text{ mA}$
Overdrive protection	$\pm 25\text{ V}$
Overdrive current	$26\text{ mA}$
Power-on state	$\pm 5\text{ mV}$
Power-on/off glitch	
PCIe/PXIe	$1.5\text{ V}$ peak for $200\text{ ms}$
USB	$1.5\text{ V}$ for $1.2\text{ s}$ , typical behavior <sup>1</sup>
Output FIFO size	$8,191$ samples shared among channels used
Data transfers	
PCIe/PXIe	DMA (scatter-gather), programmed I/O
USB	USB Signal Stream, programmed I/O
AO waveform modes	Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update
Settling time, full-scale step $15\text{ ppm}$ ( $1\text{ LSB}$ )	$2\ \mu\text{s}$
Slew rate	$20\text{ V}/\mu\text{s}$
Glitch energy at midscale transition, $\pm 10\text{ V}$ range	$10\text{ nV} \cdot \text{s}$

## External Reference

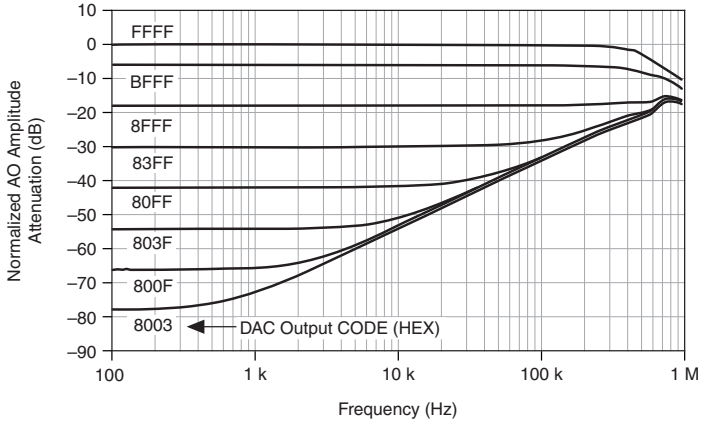
### APFI 0 characteristics

Input impedance	$10\text{ k}\Omega$
Coupling	DC
Protection, device on	$\pm 30\text{ V}$
Protection, device off	$\pm 15\text{ V}$
Range	$\pm 11\text{ V}$
Slew rate	$20\text{ V}/\mu\text{s}$

<sup>1</sup> Time period may be longer due to host system USB performance. Time period is longer during firmware updates.



**Figure 4. AO External Reference Bandwidth**



## AO Absolute Accuracy

Absolute accuracy at full-scale numbers is valid immediately following self calibration and assumes the device is operating within 10 °C of the last external calibration.

**Table 2. AO Absolute Accuracy**

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco (ppm/°C)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INL Error (ppm of Range)	Absolute Accuracy at Full Scale (µV)
10	-10	63	17	1	33	2	64	1,890
5	-5	70	8	1	33	2	64	935



**Note** Accuracies listed are valid for up to two years from the device external calibration.

## AO Absolute Accuracy Equation

$$AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$$

$$GainError = ResidualGainError + GainTempco \cdot (TempChangeFromLastInternalCal) + ReferenceTempco \cdot (TempChangeFromLastExternalCal)$$

$$OffsetError = ResidualOffsetError + OffsetTempco \cdot (TempChangeFromLastInternalCal) + INLError$$

# Digital I/O/PFI

## Static Characteristics

Number of channels	24 total, 8 (P0.<0..7>), 16 (PFI <0..7>/P1, PFI <8..15>/P2)
Ground reference	D GND
Direction control	Each terminal individually programmable as input or output
Pull-down resistor	50 k $\Omega$ typical, 20 k $\Omega$ minimum
Input voltage protection	$\pm 20$ V on up to two pins



**Caution** Stresses beyond those listed under the *Input voltage protection* specification may cause permanent damage to the device.

## Waveform Characteristics (Port 0 Only)

Terminals used	Port 0 (P0.<0..7>)
Port/sample size	Up to 8 bits
Waveform generation (DO) FIFO	2,047 samples
Waveform acquisition (DI) FIFO	255 samples
DI Sample Clock frequency	
PCIe/PXIE	0 to 10 MHz, system and bus activity dependent
USB	0 to 1 MHz, system and bus activity dependent
DO Sample Clock frequency	
PCIe/PXIE	
Regenerate from FIFO	0 to 10 MHz
Streaming from Memory	0 to 10 MHz, system and bus activity dependent

USB	
Regenerate from FIFO	0 to 10 MHz
Streaming from memory	0 to 1 MHz, system and bus activity dependent
Data transfers	
PCIe/PXIe	DMA (scatter-gather), programmed I/O
USB	USB Signal Stream, programmed I/O
Digital line filter settings	160 ns, 10.24 $\mu$ s, 5.12 ms, disable

## PFI/Port 1/Port 2 Functionality

Functionality	Static digital input, static digital output, timing input, timing output
Timing output sources	Many AI, AO, counter, DI, DO timing signals
Debounce filter settings	90 ns, 5.12 $\mu$ s, 2.56 ms, custom interval, disable; programmable high and low transitions; selectable per input

## Recommended Operating Conditions

Input high voltage ( $V_{IH}$ )	
Minimum	2.2 V
Maximum	5.25 V
Input low voltage ( $V_{IL}$ )	
Minimum	0 V
Maximum	0.8 V
Output high current ( $I_{OH}$ )	
P0.<0..7>	-24 mA maximum
PFI <0..15>/P1/P2	-16 mA maximum
Output low current ( $I_{OL}$ )	
P0.<0..7>	24 mA maximum
PFI <0..15>/P1/P2	16 mA maximum

## Digital I/O Characteristics

Positive-going threshold ( $V_{T+}$ )	2.2 V maximum
Negative-going threshold ( $V_{T-}$ )	0.8 V minimum
Delta VT hysteresis ( $V_{T+} - V_{T-}$ )	0.2 V minimum

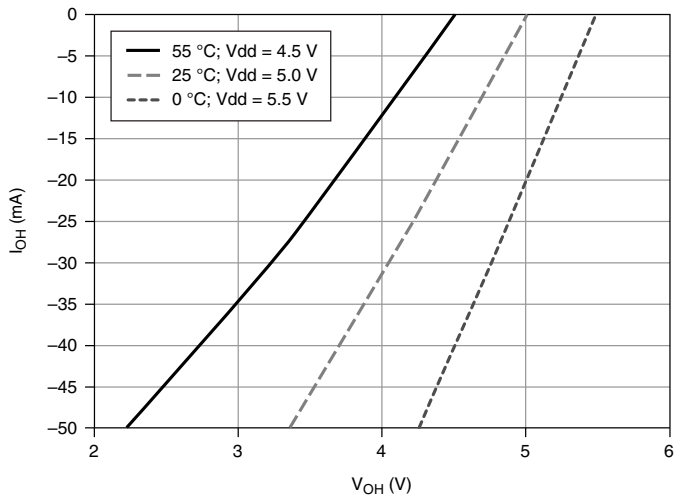
$I_{IL}$  input low current ( $V_{IN} = 0\text{ V}$ )

-10  $\mu\text{A}$  maximum

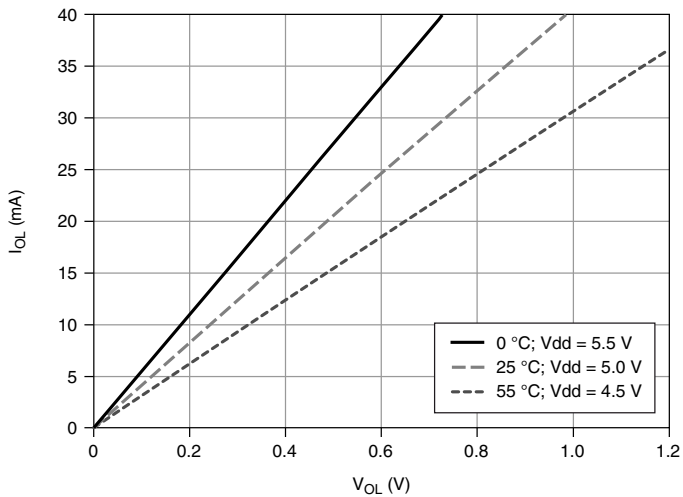
$I_{IH}$  input high current ( $V_{IN} = 5\text{ V}$ )

250  $\mu\text{A}$  maximum

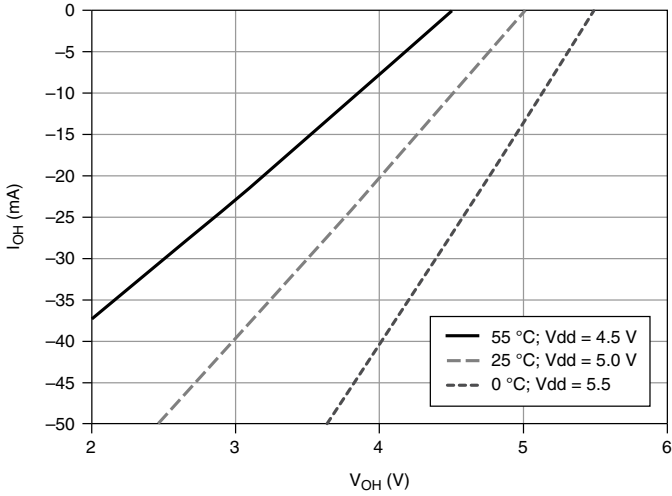
**Figure 5.** P0.<0..7>:  $I_{OH}$  versus  $V_{OH}$



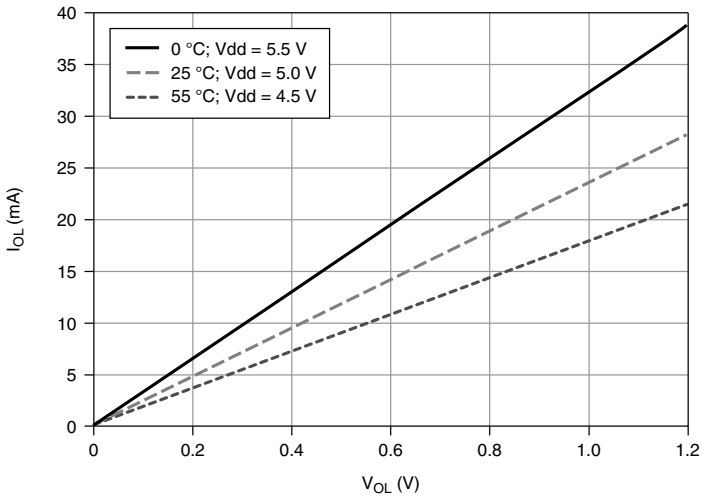
**Figure 6.** P0.<0..7>:  $I_{OL}$  versus  $V_{OL}$



**Figure 7.** PFI <0..15>/P1/P2:  $I_{OH}$  versus  $V_{OH}$



**Figure 8.** PFI <0..15>/P1/P2:  $I_{OL}$  versus  $V_{OL}$



## General-Purpose Counters

Number of counter/timers	4
Resolution	32 bits

Counter measurements	Edge counting, pulse, pulse width, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	100 MHz, 20 MHz, 100 kHz
External base clock frequency	
PCIe/USB	0 MHz to 25 MHz
PXIe	0 MHz to 25 MHz; 0 MHz to 100 MHz on PXIe_DSTAR <A,B>
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down, Sample Clock
Routing options for inputs	
PCIe	Any PFI, RTSI, analog trigger, many internal signals
PXIe	Any PFI, PXIe_DSTAR<A,B>, PXI_TRIG, PXI_STAR, analog trigger, many internal signals
USB	Any PFI, analog trigger, many internal signals
FIFO	127 samples per counter
Data transfers	
PCIe/PXIe	Dedicated scatter-gather DMA controller for each counter/timer, programmed I/O
USB	USB Signal Stream, programmed I/O

## Frequency Generator

Number of channels	1
Base clocks	20 MHz, 10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm

# Phase-Locked Loop (PLL)

Number of PLLs

1

**Table 3.** Reference Clock Locking Frequencies

Reference Signal	PCIe Locking Input Frequency (MHz)	PXIe Locking Input Frequency (MHz)	USB Locking Input Frequency (MHz)
PXIe_DSTAR<A,B>	—	10, 20, 100	—
PXI_STAR	—	10, 20	—
PXIe_CLK100	—	100	—
PXI_TRIG <0..7>	—	10, 20	—
RTSI <0..7>	10, 20	—	—
PFI <0..15>	10, 20	10, 20	10

Output of PLL

100 MHz Timebase; other signals derived from 100 MHz Timebase including 20 MHz and 100 kHz Timebases

## External Digital Triggers

Source

PCIe

Any PFI, RTSI

PXIe

Any PFI, PXIe\_DSTAR<A,B>, PXI\_TRIG, PXI\_STAR

USB

Any PFI

Polarity

Software-selectable for most signals

Analog input function

Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase

Analog output function

Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase

Counter/timer functions

Gate, Source, HW\_Arm, Aux, A, B, Z, Up\_Down, Sample Clock

Digital waveform generation (DO) function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Digital waveform acquisition (DI) function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase

## Device-to-Device Trigger Bus

### Input Source

PCIe	RTSI <0..7> <sup>2</sup>
PXIe	PXI_TRIG <0..7>, PXI_STAR, PXIe_DSTAR<A,B>
USB	None

### Output destination

PCIe	RTSI <0..7> <sup>2</sup>
PXIe	PXI_TRIG <0..7>, PXIe_DSTARC
USB	None

### Output selections

10 MHz Clock; frequency generator output; many internal signals

### Debounce filter settings

90 ns, 5.12 μs, 2.56 ms, custom interval, disable; programmable high and low transitions; selectable per input

<sup>2</sup> In other sections of this document, RTSI refers to RTSI <0..7> for NI PCIe-6363 or PXI\_TRIG <0..7> for NI PXIe-6363.



# Bus Interface

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## PCIe

Form factor	x1 PCI Express, specification v1.1 compliant
Slot compatibility	x1, x4, x8, and x16 PCI Express slots <sup>3</sup>
DMA channels	8, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1, counter/timer 2, counter/timer 3

## PXIe

Form factor	x1 PXI Express peripheral module, specification rev 1.0 compliant
Slot compatibility	x1 and x4 PXI Express or PXI Express hybrid slots
DMA channels	8, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1, counter/timer 2, counter/timer 3

All PXIe devices may be installed in PXI Express slots or PXI Express hybrid slots.

## USB

USB compatibility	USB 2.0 Hi-Speed or full-speed <sup>4</sup>
USB Signal Stream	8, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1, counter/timer 2, counter/timer 3

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<sup>3</sup> Some motherboards reserve the x16 slot for graphics use. For PCI Express guidelines, refer to [ni.com/pciexpress](http://ni.com/pciexpress).

<sup>4</sup> Operating on a full-speed bus results in lower performance, and you might not be able to achieve maximum sampling/update rates.

# Power Requirements



**Caution** The protection provided by the device can be impaired if the device is used in a manner not described in the *X Series User Manual*.

## PCIe

Without disk drive power connector installed

+3.3 V	4.6 W
+12 V	5.4 W

With disk drive power connector installed

+3.3 V	1.6 W
+12 V	5.4 W
+5 V	15 W

## PXIe

+3.3 V	1.6 W
+12 V	19.8 W



**Caution** The USB device must be powered with an NI offered AC adapter or a National Electric Code (NEC) Class 2 DC source that meets the power requirements for the device and has appropriate safety certification marks for country of use.

## USB

Power supply requirements	11 to 30 VDC, 30 W, 2 positions 3.5 mm pitch pluggable screw terminal with screw locks similar to Phoenix Contact MC 1,5/2-STF-3,5 BK
Power input mating connector	Phoenix Contact MC 1,5/2-GF-3,5 BK or equivalent

# Current Limits



**Caution** Exceeding the current limits may cause unpredictable device behavior.

## PCIe

Without disk drive power connector installed

P0/PFI/P1/P2 and +5 V terminals combined	0.59 A max
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#### With disk drive power connector installed

+5 V terminal (connector 0)	1 A max <sup>5</sup>
+5 V terminal (connector 1)	1 A max <sup>5</sup>
P0/PFI/P1/P2 combined	1 A max

#### PXIE

+5 V terminal (connector 0)	1 A max <sup>5</sup>
+5 V terminal (connector 1)	1 A max <sup>5</sup>
P0/PFI/P1/P2 and +5 V terminals combined	2 A max

#### USB

+5 V terminal	1 A max <sup>5</sup>
P0/PFI/P1/P2 and +5 V terminals combined	2 A max

## Physical Characteristics

#### Printed circuit board dimensions

PCIe	9.9 × 16.8 cm (3.9 × 6.6 in.) (half-length)
PXIE	Standard 3U PXI

#### Enclosure dimensions (includes connectors)

USB	
Mass termination	18.5 × 17.3 × 3.6 cm (7.3 × 6.8 × 1.4 in.)
Screw terminal	26.4 × 17.3 × 3.6 cm (10.4 × 6.8 × 1.4 in.)
BNC	20.3 × 18.5 × 6.8 cm (8.0 × 7.3 × 2.7 in.)

#### Weight

PCIe	161 g (5.6 oz)
PXIE	205 g (7.2 oz)
USB Mass Termination	965 g (2 lb 2.1 oz)

<sup>5</sup> Has self-resetting fuse that opens when current exceeds this specification.

USB Screw Terminal	1.413 kg (3 lb 1.8 oz)
USB BNC	1.52 kg (3 lb 5 oz)
I/O connector	
PCIe/PXLe	1 68-pin VHDCI
USB Mass Termination	1 68-pin VHDCI
USB Screw Terminal	64 screw terminals
USB BNC	20 BNCs and 30 screw terminals

**Table 4. PCIe/PXLe Mating Connectors**

Manufacturer, Part Number	Description
MOLEX 71430-0011	68-Pos Right Angle Single Stack PCB-Mount VHDCI (Receptacle)
MOLEX 74337-0016	68-Pos Right Angle Dual Stack PCB-Mount VHDCI (Receptacle)
MOLEX 71425-3001	68-Pos Offset IDC Cable Connector (Plug) (SHC68-*)

PCIe disk drive power connector	Standard ATX peripheral connector (not serial ATA)
USB screw terminal wiring/BNC screw terminal wiring	16-24 AWG

## Calibration

Recommended warm-up time	15 minutes
Calibration interval	2 years

## Maximum Working Voltage

*Maximum working voltage* refers to the signal voltage plus the common-mode voltage.

Channel to earth	11 V, Measurement Category I
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**Caution** Do not use for measurements within Categories II, III, or IV.

# Shock and Vibration

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Operational shock	30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.)
Random vibration	
Operating	5 to 500 Hz, 0.3 g <sub>rms</sub>
Nonoperating	5 to 500 Hz, 2.4 g <sub>rms</sub> (Tested in accordance with IEC-60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.)

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# Environmental

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Operating temperature	
PCIe	0 to 50 °C
PXIe	0 to 55 °C
USB	0 to 45 °C
Storage temperature	-40 to 70 °C
Operating humidity	10 to 90% RH, noncondensing
Storage humidity	5 to 95% RH, noncondensing
Pollution Degree	2
Maximum altitude	2,000 m

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Indoor use only.

# Safety

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This product meets the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1



**Note** For UL and other safety certifications, refer to the product label or the [Online Product Certification](#) section.

# Electromagnetic Compatibility

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This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- AS/NZS CISPR 11: Group 1, Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



**Note** In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia, and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



**Note** Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



**Note** For EMC declarations and certifications, refer to the [Online Product Certification](#) section.

## CE Compliance

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This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)

## Online Product Certification

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Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit [ni.com/certification](https://ni.com/certification), search by model number or product line, and click the appropriate link in the Certification column.

## Environmental Management

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NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the *Minimize Our Environmental Impact* web page at [ni.com/environment](https://ni.com/environment). This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

## Waste Electrical and Electronic Equipment (WEEE)



**EU Customers** At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit [ni.com/environment/weee](https://ni.com/environment/weee).

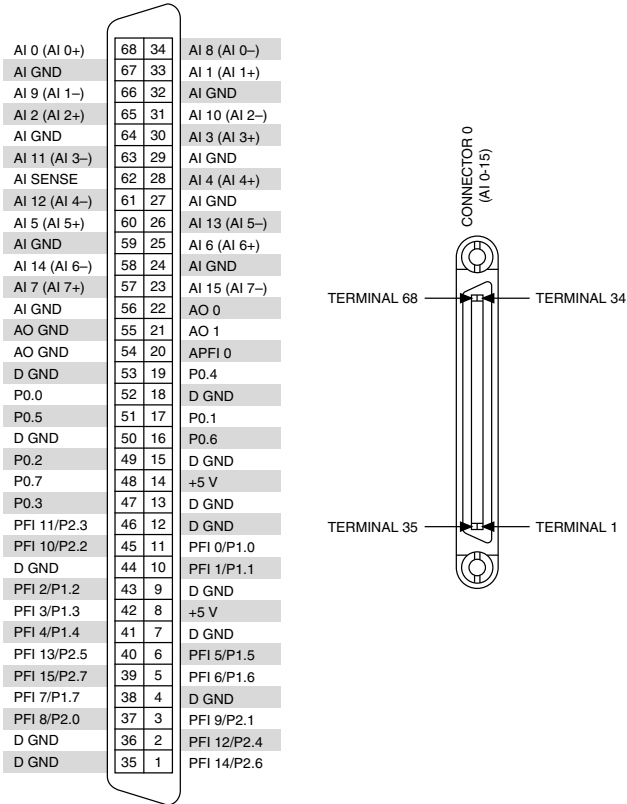
## 电子信息产品污染控制管理办法（中国 RoHS）



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# Device Pinouts

**Figure 9.** NI PCIe/PXIe-6361 Pinout

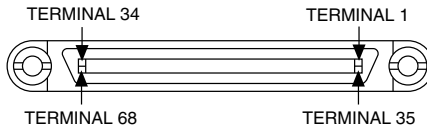




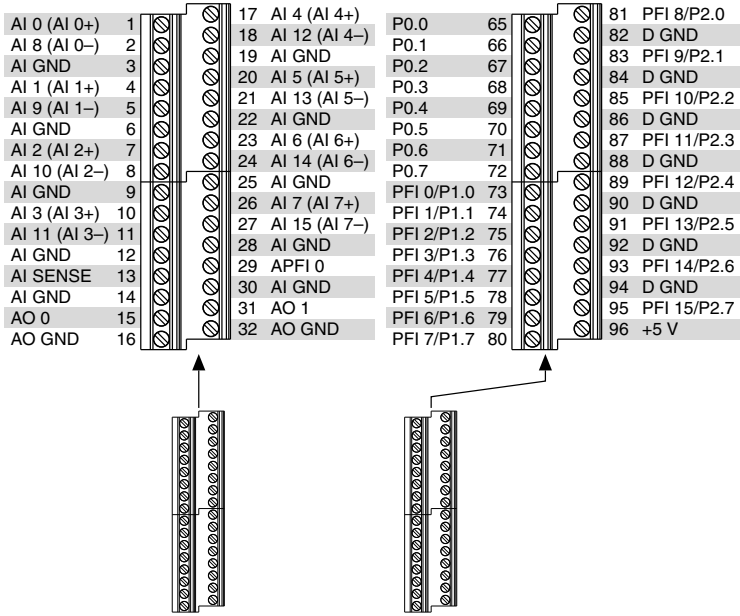
**Figure 10. NI USB-6361 Mass Termination Pinout**

AI 0 (AI 0+)	68	34	AI 8 (AI 0-)
AI GND	67	33	AI 1 (AI 1+)
AI 9 (AI 1-)	66	32	AI GND
AI 2 (AI 2+)	65	31	AI 10 (AI 2-)
AI GND	64	30	AI 3 (AI 3+)
AI 11 (AI 3-)	63	29	AI GND
AI SENSE	62	28	AI 4 (AI 4+)
AI 12 (AI 4-)	61	27	AI GND
AI 5 (AI 5+)	60	26	AI 13 (AI 5-)
AI GND	59	25	AI 6 (AI 6+)
AI 14 (AI 6-)	58	24	AI GND
AI 7 (AI 7+)	57	23	AI 15 (AI 7-)
AI GND	56	22	AO 0
AO GND	55	21	AO 1
AO GND	54	20	APFI 0
D GND	53	19	P0.4
P0.0	52	18	D GND
P0.5	51	17	P0.1
D GND	50	16	P0.6
P0.2	49	15	D GND
P0.7	48	14	+5 V
P0.3	47	13	D GND
PFI 11/P2.3	46	12	D GND
PFI 10/P2.2	45	11	PFI 0/P1.0
D GND	44	10	PFI 1/P1.1
PFI 2/P1.2	43	9	D GND
PFI 3/P1.3	42	8	+5 V
PFI 4/P1.4	41	7	D GND
PFI 13/P2.5	40	6	PFI 5/P1.5
PFI 15/P2.7	39	5	PFI 6/P1.6
PFI 7/P1.7	38	4	D GND
PFI 8/P2.0	37	3	PFI 9/P2.1
D GND	36	2	PFI 12/P2.4
D GND	35	1	PFI 14/P2.6

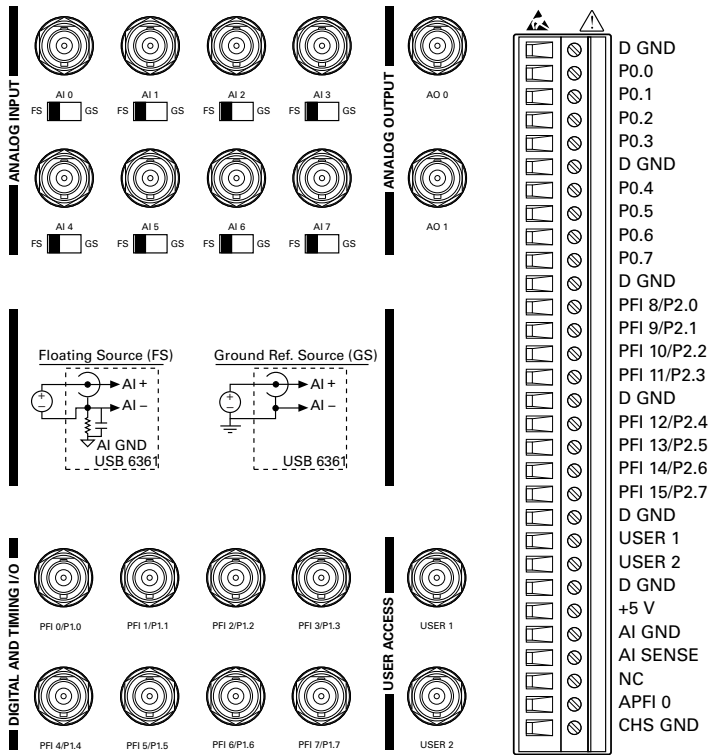
CONNECTOR 0  
(AI 0-15)



**Figure 11. NI USB-6361 Screw Terminal Pinout**



**Figure 12. NI USB-6361 BNC Front Panel and Pinout**



⊙ POWER



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